IN THE US PATENT AND TRADEMARK OFFICE				
	2907			
In re Application of: Yagi	Group Art Unit:			
Application No:	Batch:			
Filed: Herewith	Examiner:			
For: Semiconductor Element and Device for Detecting Organic Molecules and Method for Measuring Organic Molecules Using Same	Date: December 21, 2001 CO			
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INFORMATION	DISCLOSURE STATEMENT			
ASSISTANT COMMISSIONER FOR PATEN Washington, D.C. 20231 Sir:	NTS			
This Information Disclosure Stateme	ent is submitted:			
under 37 CFR 1.97 (c) tog statement under 3 a \$240 fee under 3	7 CFR 1.97(e), or			
of this information dis				
Applicant submit herewith Form PTC examination of this application and for which 37 CFR 1.56.	1449 information that may be material to the high there may be a duty to disclose in accordance with			
are enclosed. The information listed in the attack submitted to the Office in a prior application	s, or other information listed on the Form PTO 1449 hed Form PTO 1449 was previously cited by or , No. , upon which the present application \$\circ\$ 120. Consequently, copies of this information are			

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☐ A concise explanation of the relevant is attached hereto;	ce, as presently understood, of such information				
the foreign language document was cited in a search report or other action by a reign patent office in a counterpart application, thus an English language version of the search eport or action which indicates the degree of relevance found by that office is listed on Form TO 1449 and enclosed herewith.					
Res	spectfully submitted,				
By:	rk M. Meininger, Reg. No. 32,428				
805 SW Broadway #2740					

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¹ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

² Applicant is to place check mark in the "T" column if an English translation is attached for the cited reference.